

EVG[®]7300

UV Nanoimprint Lithography System



Introduction

Multifunctional UV Nanoimprint Lithography system up to 300 mm featuring SmartNIL® technology, lens molding and lens stacking in one tool

The versatile EVG7300 UV Nanoimprint Lithography System can support multiple related UV processes: SmartNIL, Wafer Level Optics (WLO) and Stacking – three capabilities merged in one flexible tool.

It is a standalone system based on the modularized and improved SmartNIL module, which can be configured depending on handling and automation levels. Supporting wafer sizes from 150 mm up to 300 mm and featuring high-precision alignment down to 300 nm, advanced process control and high throughput, the EVG7300 can serve advanced R&D up to high-volume manufacturing (HVM) needs for a variety of freeform and high precision nano- and micro optical components and devices. For the necessity of integrated pre- and post-process flows in HVM environments, the module can be integrated into the HERCULES NIL system.

This multi-functional system is designed to serve a wide range of emerging applications involving micro- and nanoimprints as well as UV-stacking of functional layers. Thus, the equipment enables enhanced process performance for wafer-level optics (WLO), nanophotonics, metasurfaces and biomedical chips. This is closely related to the industry needs for novel optical sensors and optoelectronics to enable e.g. autonomous driving, micro lens arrays and projectors in automotive and decorative lighting, diffractive optics for biometric authentication as well as emerging trends for sophisticated meta-lenses. First applications utilizing this technology already exist today in the field of advanced biomedical devices and augmented reality waveguides where nanoimprinting enables high quality manufacturing of complex designs.

Features

- Advanced Alignment Capabilities
 - Live alignment <± 300 nm (process dependent)
- UV LED lamp up to high power 500 mW/cm²
 - > 90 % uniformity
 - Optional: Dual wavelength operation:
 365 nm and 405 nm
 - 305 nm anu 405 nm
 - Different exposure modes
- Optional Features
 - Optical wedge error compensation (WEC)
 - Temperature-controlled chuck
- Industry leading process performance
 - Resolution down to single nanometer range
 - Very precise residual layer control

Contact

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Technical Specification Sheet

EVG®7300 UV Nanoimprint Lithography System



Technical Data

Supported wafer diameter (substrate size)	Up to 300 mm
Resolution	≤ 10 nm (depending on process and material*)
Supported Process	SmartNIL® Lens Molding Lens Stacking
Exposure source	UV LED lamp up to high power (500 mW/cm ²) Dual wavelength operation possible: 365 nm or 405 nm
Alignment	<± 300 nm (process dependent)
Stamp separation	Fully Automated
Working stamp fabrication	Supported

*master needs to be provided by customer

Flexibility

UV-NIL system enabling three UV processes in one tool: SmartNIL®, WLO and Stacking

Precisely controlled multistep process including alignment, contacting and UV-curing

Low-force automated stamp detachment for SmartNIL® and WLO

Scalability

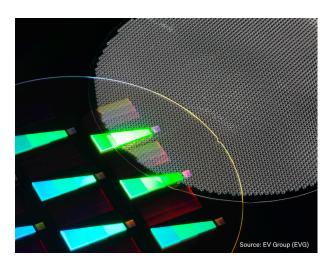
Processing wafers up to 300 mm substrates

Modularity

Standalone module, as well integration into HERCULES® NIL

Substrate handling: from manual loading to fully automated operation

Optional automatic stamp loading for SmartNIL® allowing continuous mode operation



SmartNIL® structured augmented reality (AR) waveguides and wafer-level-mircolenses imprint showcasing the application versatility of the new EVG®7300

Get in touch:

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